

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination HAYASHI ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY.Y	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY.	Country	Name	Classification
	N	JP 06116266 A	04-1994	Japan	SUGIMURA et al.	
	O					
	P					
	Q					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages).
	U	Translation of JP 06116266 A
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